10/587268 IAP11 Rec'd PCT/PTO 26 JUL 2006

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Hiroaki TAKAIWA et al.

New U.S. National Phase of PCT/JP2005/001225

Filed: July 26, 2006 Docket No.: 128865

For: EXPOSURE APPARATUS AND DEVICE MANUFACTURING METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of one or more non-English language reference is discussed in the present specification. See Reference 48.
- 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See References 19, 21, 22 and 24-26.
- 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 5. An English language Abstract of one or more non-English language reference is attached hereto. See References 19-48, 50 and 52-59.
- 6. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 19, 21, 22, 24, 25, 28, 30, 31, 33-35, 37, 39-41, 44-48 and 56-59.

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7. Reference 1 corresponds to reference 21. Reference 2 corresponds to reference 24. Reference 16 corresponds to reference 25. Reference 20 corresponds to reference 19. Reference 23 corresponds to reference 22.

Respectfully submitted,

Mario A. Costantino Registration No. 33,565

Joel S. Armstrong Registration No. 36,430

MAC:JSA/jdb

Date: July 26, 2006

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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE TION DISCLOSURE STATEMENT		ATTY DOCKET NO. 128865		APPLICATION NO. New U.S. National Phase of PCT/JP2005/001225			
						PC1/JP200	3/001223		
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